Tailoring x-ray tomography techniques for cultural heritage research
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Citation

Version: Publisher's Version
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Downloaded from: https://hdl.handle.net/1887/3754491

Note: To cite this publication please use the final published version (if applicable).
Francien Bossema was born in 1994 in Amsterdam, The Netherlands. She completed her secondary education in 2011 at the Vossius Gymnasium, Amsterdam, The Netherlands. She obtained two bachelors degrees in Mathematics and Physics & Astronomy from the Vrije Universiteit Amsterdam in 2015. During her bachelor studies she took a minor in Humanities at Greenwich University, London, United Kingdom. She obtained her master’s degree (cum laude) in Mathematics focussing on Applied Mathematics, with an additional specialisation in Science Communication & Society in 2018 from Leiden University, The Netherlands. During her master degree she took internships at De Volkskrant (Amsterdam, The Netherlands) and Instituto de Astrofísica y Ciencias do Espaço (Lisbon, Portugal). From 2018-2023 she took a Ph.D. degree under supervision of prof. dr. K. J. Batenburg and prof. dr. E. Hermens at Centrum Wiskunde & Informatica, the national research institute for mathematics and computer science in Amsterdam, The Netherlands, in collaboration with the Rijksmuseum, Amsterdam. In 2022, she performed part of her research at the British Museum (London, United Kingdom) during an eight-month research placement. She is currently engaged as postdoctoral Migelien Gerritzen Fellow at the Rijksmuseum, Amsterdam, as Fellow at the eScience Center, Amsterdam and as postdoctoral researcher at the Centrum Wiskunde & Informatica. More information, such as presentations, blogs and videos, can be found on her website: fgbossema.github.io.